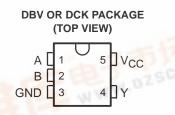
查询SN74AUP1G08YZPR供应商

捷多邦,专业PCB打样工厂,24小时加急**SN7**4AUP1G08 LOW-POWER SINGLE 2-INPUT POSITIVE-AND GATE

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- Available in the Texas Instruments NanoStar[™] and NanoFree[™] Packages
- Low Static-Power Consumption;
 I_{CC} = 0.9 μA Max
- Low Dynamic-Power Consumption; C_{pd} = 4.3 pF Typ at 3.3 V
- Low Input Capacitance; C_i = 1.5 pF Typ
- Low Noise Overshoot and Undershoot <10% of V_{CC}
- I_{off} Supports Partial-Power-Down Mode Operation
- Schmitt-Trigger Action Allows Slow Input Transition and Better Switching Noise Immunity at the Input (V_{hvs} = 250 mV Typ at 3.3 V)



- Wide Operating V_{CC} Range of 0.8 V to 3.6 V
- Optimized for 3.3-V Operation
- 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- t_{pd} = 4.3 ns Max at 3.3 V
- Suitable for Point-to-Point Applications
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22

 2000-V Human-Body Model
 - (A114-B, Class II)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- ESD Protection Exceeds ±5000 V With Human-Body Model

YEP OR YZP PACKAGE (BOTTOM VIEW)

GND 03 40 В 02 01 50 Δ Vcc

description/ordering information

The AUP family is TI's premier solution to the industry's low-power needs in battery-powered portable applications. This family ensures a very low static- and dynamic-power consumption across the entire V_{CC} range of 0.8 V to 3.6 V, resulting in increased battery life (see Figure 1). This product also maintains excellent signal integrity (see the very low undershoot and overshoot characteristics shown in Figure 2).

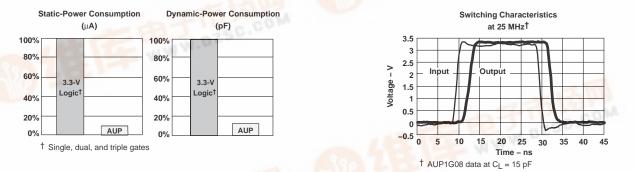


Figure 2. Excellent Signal Integrity

This single 2-input positive-AND gate performs the Boolean function $Y = A \cdot B$ or $Y = \overline{A} + \overline{B}$ in positive logic. NanoStarTM and NanoFreeTM package technology is a major breakthrough in IC packaging concepts, using the die as the package.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

hoStar and NanoFree are trademarks of Texas Instruments.

Figure 1. AUP – The Lowest-Power Family



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description/ordering information (continued)

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

ORDERING INFORMATION

TA	PACKAGE [†]	ORDERABLE PART NUMBER	TOP-SIDE MARKING [‡]	
	NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YEP	Tape and reel	SN74AUP1G08YEPR	
–40°C to 85°C	NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free)	Tape and reel	SN74AUP1G08YZPR	HE_
	SOT (SOT-23) – DBV	Tape and reel	SN74AUP1G08DBVR	H08_
	SOT (SC-70) – DCK	Tape and reel	SN74AUP1G08DCKR	HE_

⁺ Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

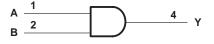
[‡]DBV/DCK: The actual top-side marking has one additional character that designates the assembly/test site.

YEP/YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition $(1 = \text{SnPb}, \bullet = \text{Pb-free})$.

FUNCTION TABLE

INP	JTS	OUTPUT
Α	В	Y
L	L	L
L	Н	L
н	L	L
Н	Н	Н

logic diagram (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}
Voltage range applied to any output in the high-impedance or power-off state, V _O (see Note 1) -0.5 V to 4.6 V
Output voltage range in the high or low state, V_O (see Note 1)
Input clamp current, I _{IK} (V _I < 0)
Output clamp current, I _{OK} (V _O < 0)
Continuous output current, I _O ±20 mA
Continuous current through V _{CC} or GND ±50 mA
Package thermal impedance, θ_{JA} (see Note 2): DBV package
DCK package
YEP/YZP package 132°C/W
Storage temperature range, T _{stg}

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

			MIN	MAX	UNIT				
VCC	Supply voltage		0.8	3.6	V				
		V _{CC} = 0.8 V	VCC						
	Literation of the sector of the sec	V _{CC} = 1.1 V to 1.95 V	$0.65 \times V_{CC}$						
VIH	High-level input voltage	$V_{CC} = 2.3 V \text{ to } 2.7 V$	1.6		V				
		$V_{CC} = 3 V \text{ to } 3.6 V$	2						
		$V_{CC} = 0.8 V$		0					
	Level and Second configure	V _{CC} = 1.1 V to 1.95 V		$0.35 \times V_{CC}$					
VIL	Low-level input voltage	V_{CC} = 2.3 V to 2.7 V		0.7	V				
		$V_{CC} = 3 V \text{ to } 3.6 V$		0.9					
VI	Input voltage		0	3.6	V				
VO	Output voltage		0	V _{CC}	V				
	High-level output current	V _{CC} = 0.8 V		-20	μΑ				
		V _{CC} = 1.1 V		-1.1					
		V _{CC} = 1.4 V		-1.7					
ЮН		V _{CC} = 1.65		-1.9	mA				
		V _{CC} = 2.3 V		-3.1					
		$V_{CC} = 3 V$		-4					
		$V_{CC} = 0.8 V$		20	μΑ				
		V _{CC} = 1.1 V		1.1					
1	Low lovel entering entering	$V_{CC} = 1.4 V$		1.7					
IOL	Low-level output current	V _{CC} = 1.65 V		1.9	mA				
		V _{CC} = 2.3 V 3.		3.1]				
		V _{CC} = 3 V		4					
$\Delta t / \Delta v$	Input transition rise or fall rate	V_{CC} = 0.8 V to 3.6 V		200	ns/V				
TA	Operating free-air temperature		-40	85	°C				

recommended operating conditions (see Note 3)

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

				T,	A = 25°0	;	T _A = −40°C	; TO 85°C		
PARAMETER	TEST CONDITIO	DNS	VCC	MIN	TYP	MAX	MIN	MAX	UNIT	
	I _{OH} = -20 μA		0.8 V to 3.6 V	V _{CC} – 0.1			V _{CC} – 0.1			
	I _{OH} = -1.1 mA		1.1 V	$0.75 \times V_{CC}$			$0.7 \times V_{CC}$			
	$I_{OH} = -1.7 \text{ mA}$		1.4 V	1.11			1.03		v	
N/	I _{OH} = -1.9 mA		1.65 V	1.32			1.3			
V _{OH}	$I_{OH} = -2.3 \text{ mA}$		2.2.V	2.05			1.97		V	
	I _{OH} = -3.1 mA		2.3 V	1.9			1.85			
	$I_{OH} = -2.7 \text{ mA}$		2.1/	2.72			2.67			
	$I_{OH} = -4 \text{ mA}$		3 V	2.6			2.55			
	I _{OL} = 20 μA		0.8 V to 3.6 V			0.1		0.1		
	I _{OL} = 1.1 mA		1.1 V			$0.3 \times V_{CC}$		$0.3 \times V_{CC}$		
	I _{OL} = 1.7 mA		1.4 V			0.31		0.37		
	I _{OL} = 1.9 mA		1.65 V			0.31		0.35	V	
V _{OL}	I _{OL} = 2.3 mA		0.01/			0.31		0.33		
	I _{OL} = 3.1 mA		2.3 V			0.44		0.45		
	I _{OL} = 2.7 mA		<u> </u>			0.31		0.33		
	$I_{OL} = 4 \text{ mA}$		3 V			0.44		0.45		
II A or B input	$V_I = GND$ to 3.6 V		0 V to 3.6 V			0.1		0.5	μA	
l _{off}	V_{I} or $V_{O} = 0 V$ to 3.6	V	0 V			0.2		0.6	μA	
ΔI_{off}	$V_{I} \text{ or } V_{O} = 0 \text{ V to } 3.6$	V	0 V to 0.2 V			0.2		0.6	μA	
ICC	V _I = GND or (V _{CC} to 3.6 V)	IO = 0	0.8 V to 3.6 V			0.5		0.9	μΑ	
ΔICC	$V_{I} = V_{CC} - 0.6 V^{\dagger}$	$I_{O} = 0$	3.3 V			40		50	μA	
			0 V		1.5				_	
Ci	$V_{I} = V_{CC}$ or GND		3.6 V		1.5				pF	
Co	V _O = GND		0 V		3				рF	

⁺ One input at V_{CC} – 0.6 V, other input at V_{CC} or GND

switching characteristics over recommended operating free-air temperature range, $C_L = 5 \text{ pF}$ (unless otherwise noted) (see Figures 3 and 4)

PARAMETER			T _A = 25°C			T _A = - TO 8	UNIT		
	(INPUT)	(OUTPUT)		MIN	TYP	MAX	MIN	MAX	
			0.8 V		18				
			$1.2~\text{V}\pm0.1~\text{V}$	2.6	7.3	12.8	2.1	15.6	
+ .	A as D	×	$1.5~\text{V}\pm0.1~\text{V}$	1.4	5.2	8.7	0.9	10.3	
^t pd	A or B	Y	$1.8~\text{V}\pm0.15~\text{V}$	1	4.2	6.6	0.5	8.2	ns
			$2.5~\text{V}\pm0.2~\text{V}$	1	3	4.4	0.5	5.5	
			$3.3~\text{V}\pm0.3~\text{V}$	1	2.4	3.5	0.5	4.3	



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switching characteristics over recommended operating free-air temperature range, $C_L = 10 \text{ pF}$ (unless otherwise noted) (see Figures 3 and 4)

PARAMETER	FROM (INPUT)	TO	Vcc	т,	ק = 25°C	;	T _A = - TO 8		UNIT
	(INPUT)	(OUTPUT)		MIN	TYP	MAX	MIN	MAX	
			0.8 V		21				
			$1.2~V\pm0.1~V$	1.5	8.5	14.7	1	17.2	
+ .	A an D		$1.5~V\pm0.1~V$	1	6.2	10	0.5	11.3	
^t pd	A or B	Y	$1.8~\text{V}\pm0.15~\text{V}$	1	5	7.7	0.5	9	ns
			$2.5~\text{V}\pm0.2~\text{V}$	1	3.6	5.2	0.5	6.1	
			$3.3~\text{V}\pm0.3~\text{V}$	1	2.9	4.2	0.5	4.7	

switching characteristics over recommended operating free-air temperature range, $C_L = 15 \text{ pF}$ (unless otherwise noted) (see Figures 3 and 4)

PARAMETER	FROM	TO	Vcc	т,	₄ = 25°C	;	T _A = - TO 8		UNIT
	(INPUT)	(OUTPUT)		MIN	TYP	MAX	MIN	MAX	
			0.8 V		24				
			$1.2 \text{ V} \pm 0.1 \text{ V}$	3.6	9.9	16.3	3.1	19.9	
+ .	A as D	X	$1.5~\text{V}\pm0.1~\text{V}$	2.3	7.2	11.1	1.8	13.2	
^t pd	A or B	Y	$1.8~\text{V}\pm0.15~\text{V}$	1.6	5.8	8.7	1.1	10.6	ns
			$2.5~\text{V}\pm0.2~\text{V}$	1	4.3	5.9	0.5	7.3	ns
			$3.3~\text{V}\pm0.3~\text{V}$	1	3.4	4.8	0.5	5.9	

switching characteristics over recommended operating free-air temperature range, $C_L = 30 \text{ pF}$ (unless otherwise noted) (see Figures 3 and 4)

PARAMETER			T _A = 25°C			T _A = - TO 8	UNIT		
	(INPUT)	(OUTPUT)		MIN	TYP	MAX	MIN	MAX	
			0.8 V		32.8				
			$1.2 \text{ V} \pm 0.1 \text{ V}$	4.9	13.1	20.9	4.4	25.5	
. .	A		1.5 V ± 0.1 V	3.4	9.5	14.2	2.9	16.9	
^t pd	A or B	Y	$1.8 \text{ V} \pm 0.15 \text{ V}$	2.5	7.7	11	2	13.5	ns
			$2.5~V\pm0.2~V$	1.8	5.7	7.6	1.3	9.4	
			$3.3~\text{V}\pm0.3~\text{V}$	1.5	4.7	6.2	1	7.5	

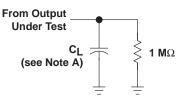
operating characteristics, T_A = 25°C

	PARAMETER	TEST CONDITIONS	V _{CC}	TYP	UNIT
			0.8 V	4	
			1.2 V ± 0.1 V	4	
	Device discipation consolitones	6 40 MUL	1.5 V ± 0.1 V	4	pF
C _{pd}	Power dissipation capacitance	f = 10 MHz	$1.8 \text{ V} \pm 0.15 \text{ V}$	4	
			$2.5~\text{V}\pm0.2~\text{V}$	4.1	
			$3.3~\text{V}\pm0.3~\text{V}$	4.3	



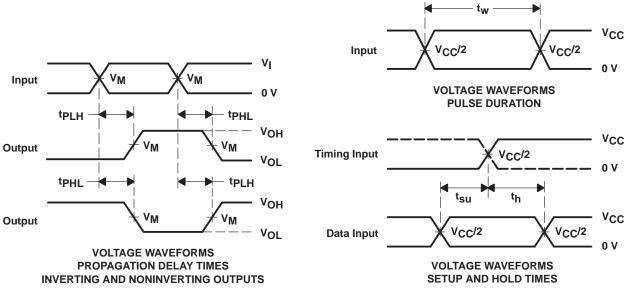
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PARAMETER MEASUREMENT INFORMATION (Propagation Delays, Setup and Hold Times, and Pulse Duration)



LOAD CIRCUIT

	V _{CC} = 0.8 V	V _{CC} = 1.2 V ± 0.1 V	V _{CC} = 1.5 V ± 0.1 V	V _{CC} = 1.8 V ± 0.15 V	V _{CC} = 2.5 V ± 0.2 V	V _{CC} = 3.3 V ± 0.3 V
CL	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
V _M	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2
VI	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}



NOTES: A. C_L includes probe and jig capacitance.

B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , slew rate \geq 1 V/ns.

C. The outputs are measured one at a time, with one transition per measurement.

D. tpl H and tpHI are the same as tpd.

E. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms



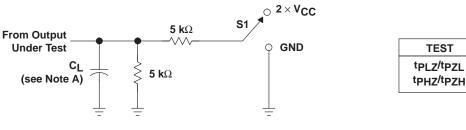
TEST

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S1 $2 \times V_{CC}$

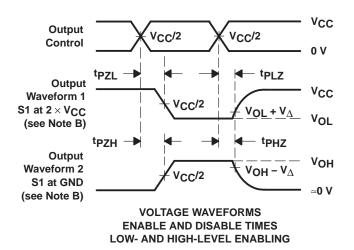
GND

PARAMETER MEASUREMENT INFORMATION (Enable and Disable Times)



LOAD CIRCUIT

	V _{CC} = 0.8 V	V _{CC} = 1.2 V ± 0.1 V	V _{CC} = 1.5 V ± 0.1 V	V _{CC} = 1.8 V ± 0.15 V	V _{CC} = 2.5 V ± 0.2 V	V _{CC} = 3.3 V ± 0.3 V
СL	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
V _M	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2
VI	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}
V _Δ	0.1 V	0.1 V	0.1 V	0.15 V	0.15 V	0.3 V



- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_Q = 50 Ω , slew rate \geq 1 V/ns.
 - D. The outputs are measured one at a time, with one transition per measurement.
 - E. tpl 7 and tpH7 are the same as tdis.
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. All parameters and waveforms are not applicable to all devices.

Figure 4. Load Circuit and Voltage Waveforms





PACKAGE OPTION ADDENDUM

25-Feb-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN74AUP1G08DBVR	ACTIVE	SOT-23	DBV	5	3000	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G08DBVT	ACTIVE	SOT-23	DBV	5	250	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G08DCKR	ACTIVE	SC70	DCK	5	3000	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G08DCKT	ACTIVE	SC70	DCK	5	250	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G08YEPR	ACTIVE	WCSP	YEP	5	3000	None	SNPB	Level-1-260C-UNLIM
SN74AUP1G08YZPR	ACTIVE	WCSP	YZP	5	3000	Pb-Free (RoHS)	SNAGCU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not yet available Lead (Pb-Free).

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

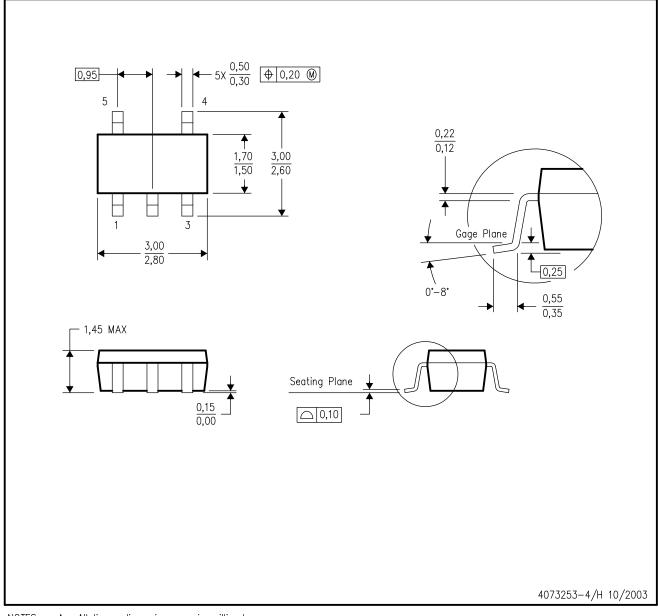
⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion.
 - D. Falls within JEDEC MO-178 Variation AA.

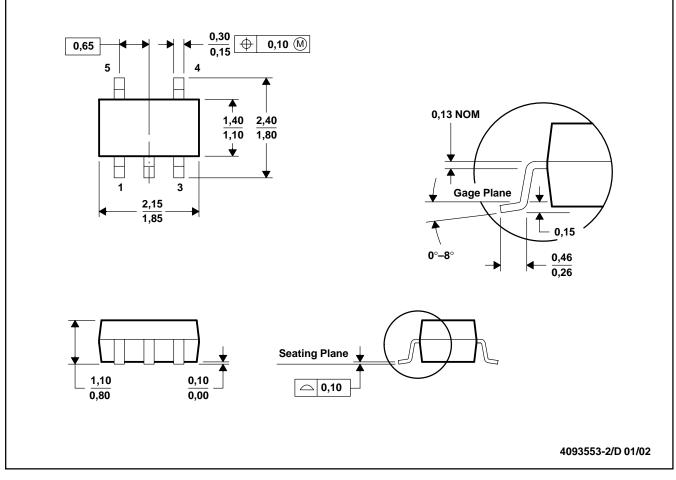


MECHANICAL DATA

MPDS025C - FEBRUARY 1997 - REVISED FEBRUARY 2002

DCK (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



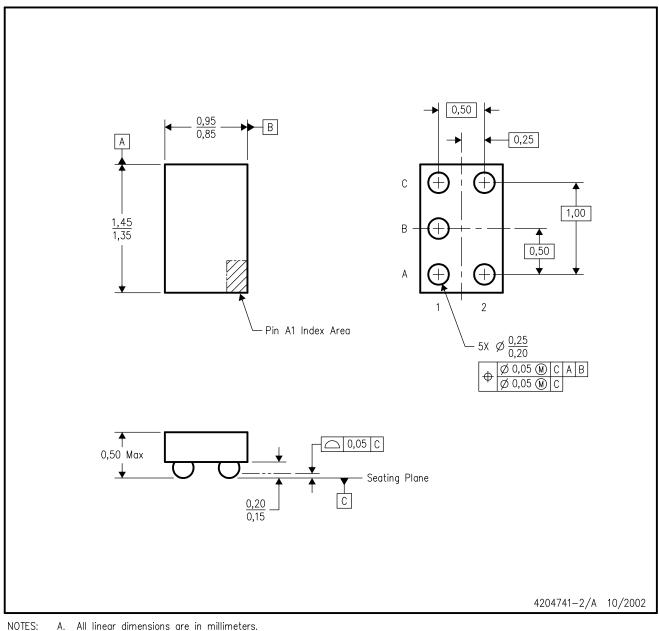
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion.
- D. Falls within JEDEC MO-203



YZP (R-XBGA-N5)

DIE-SIZE BALL GRID ARRAY



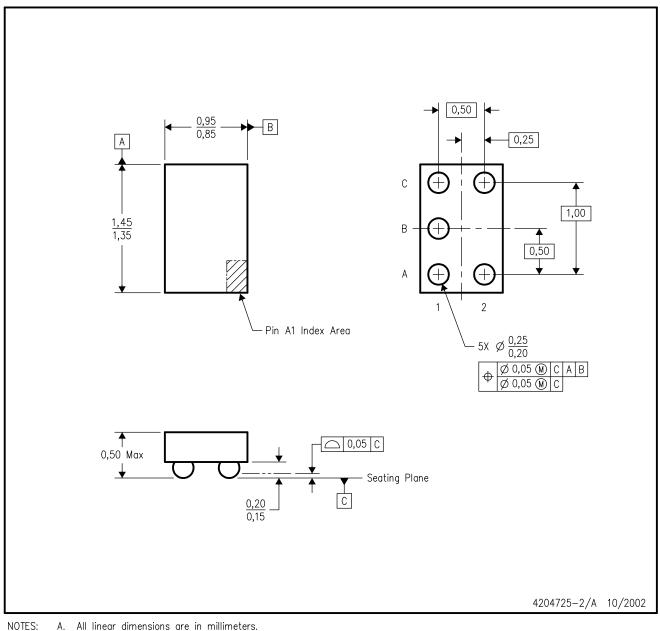
NOTES:

- This drawing is subject to change without notice. Β.
- C. NanoFree™ package configuration.
- D. This package is lead-free. Refer to the 5 YEP package (drawing 4204725) for tin-lead (SnPb).

NanoFree is a trademark of Texas Instruments.

YEP (R-XBGA-N5)

DIE-SIZE BALL GRID ARRAY



NOTES:

- This drawing is subject to change without notice. Β.
- C. NanoStar™ package configuration.
- D. This package is tin-lead (SnPb). Refer to the 5 YZP package (drawing 4204741) for lead-free.

NanoStar is a trademark of Texas Instruments.

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